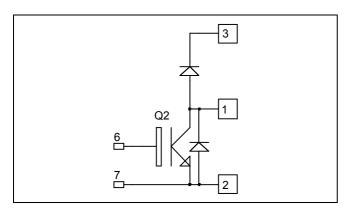
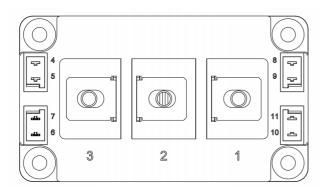


# Boost chopper Trench + Field Stop IGBT3 Power Module





# APTGT200DA170D3G

# $V_{CES} = 1700V$ $I_{C} = 200A$ @ Tc = 80°C

## Application

- AC and DC motor control
- Switched Mode Power Supplies
- Power Factor Correction

### Features •

- Trench + Field Stop IGBT3 Technology
  - Low voltage drop
  - Low tail current
  - Switching frequency up to 20 kHz
  - Soft recovery parallel diodes
  - Low diode VF
  - Low leakage current
  - RBSOA and SCSOA rated
- Kelvin emitter for easy drive
- High level of integration
- M6 power connectors

# Benefits

- Stable temperature behavior
- Very rugged
- Direct mounting to heatsink (isolated package)
- Low junction to case thermal resistance
- Easy paralleling due to positive  $T_C$  of  $V_{CEsat}$
- RoHS Compliant

# Absolute maximum ratings

	Symbol	Parameter		Max ratings	Unit
	V <sub>CES</sub>	Collector - Emitter Breakdown Voltage		1700	V
	I <sub>C</sub>	Continuous Collector Current	$T_C = 25^{\circ}C$	310	
	IC	Continuous Conector Current	$T_C = 80^{\circ}C$	200	Α
	I <sub>CM</sub>	Pulsed Collector Current	$T_C = 25^{\circ}C$	400	
	V <sub>GE</sub>	Gate – Emitter Voltage		$\pm 20$	V
	P <sub>D</sub>	Maximum Power Dissipation	$T_C = 25^{\circ}C$	1250	W
]	RBSOA	Reverse Bias Safe Operating Area	$T_j = 125^{\circ}C$	400A@1650V	

CAUTION: These Devices are sensitive to Electrostatic Discharge. Proper Handling Procedures Should Be Followed. See application note APT0502 on www.microsemi.com

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# All ratings (a) $T_j = 25^{\circ}C$ unless otherwise specified

Electrical Characteristics									
Symbol	Characteristic	Test Conditions	Min	Тур	Max	Unit			
I <sub>CES</sub>	Zero Gate Voltage Collector Current	$V_{GE} = 0V, V_{CE} = 1700V$				3	mA		
V <sub>CE(on)</sub>	) Collector Emitter on Voltage	$\label{eq:VGE} \begin{array}{ll} V_{GE} = 15V & T_j = 25^\circ C \\ I_C = 200A & T_j = 125^\circ C \end{array}$	$T_j = 25^{\circ}C$		2.0	2.5	V		
V CE(on)				2.4		v			
V <sub>GE(th)</sub>	Gate Threshold Voltage	$V_{GE} = V_{CE}, I_C = 8 \text{ mA}$		5.2	5.8	6.4	V		
I <sub>GES</sub>	Gate – Emitter Leakage Current	$V_{GE} = 20V, V_{CE} = 0V$				400	nA		

# **Dynamic Characteristics**

Symbol	Characteristic	Test Conditions		Min	Тур	Max	Unit
Cies	Input Capacitance	$V_{GE} = 0V, V_{CE} = 25V$ f = 1MHz			18		nF
C <sub>res</sub>	Reverse Transfer Capacitance				0.6		III.
Q <sub>G</sub>	Gate charge	V <sub>GE</sub> =±15V, I <sub>C</sub> =200A V <sub>CE</sub> =900V			2.3		μC
T <sub>d(on)</sub>	Turn-on Delay Time	Inductive Switching (25°C)			280		
Tr	Rise Time	$V_{GE} = \pm 15V$			80		
T <sub>d(off)</sub>	Turn-off Delay Time	$V_{Bus} = 900V$ $I_{C} = 200A$ $R_{G} = 6.8\Omega$			850		ns
$T_{\rm f}$	Fall Time				120		
T <sub>d(on)</sub>	Turn-on Delay Time	Inductive Switching (125°C) $V_{GE} = \pm 15V$ $V_{Bus} = 900V$ $I_C = 200A$ $R_G = 6.8\Omega$			300		
Tr	Rise Time				100		ns
T <sub>d(off)</sub>	Turn-off Delay Time				1000		
T <sub>f</sub>	Fall Time				200		
Eon		$V_{GE} = \pm 15V$	$T_i = 25^{\circ}C$		58		
Lon	Turn On Energy	$V_{Bus} = 900V$	$T_{i} = 125^{\circ}C$		78		mJ
E <sub>off</sub>	Turn Off Energy	$I_{\rm C} = 200 {\rm A}$	$T_j = 25^{\circ}C$		43		1115
Loff	Turn On Energy	$R_{\rm G} = 6.8\Omega \qquad \qquad T_{\rm j} = 125^{\circ}{\rm C}$	$T_i = 125^{\circ}C$		63		
I <sub>sc</sub>	Short Circuit data	$V_{GE} \le 15V$ ; $V_{Bus} = 1000V$ $t_p \le 10\mu s$ ; $T_1 = 125^{\circ}C$			800		А

# Reverse diode ratings and characteristics

Symbol	Characteristic	Test Conditions		Min	Тур	Max	Unit
V <sub>RRM</sub>	Maximum Peak Repetitive Reverse Voltage			1700			V
I <sub>RRM</sub>	Maximum Reverse Leakage Current	V <sub>R</sub> =1700V	$T_j = 25^{\circ}C$			750	μA
1 <sub>RRM</sub>			$T_{j} = 125^{\circ}C$			1000	μΛ
I <sub>F</sub>	DC Forward Current		$Tc = 80^{\circ}C$		200		А
$V_{\rm F}$	Diode Forward Voltage	$I_{\rm F} = 200 {\rm A}$	$T_j = 25^{\circ}C$		1.8	2.2	v
• F	blode forward voluge	1F 20071	$T_i = 125^{\circ}C$		1.9		*
t <sub>rr</sub>	Reverse Recovery Time	$I_F = 200A$ $V_R = 900V$ $di/dt = 3200A/\mu s$	$T_j = 25^{\circ}C$		385		ns
ι <sub>rr</sub>			$T_{j} = 125^{\circ}C$		490		115
Q <sub>rr</sub>	Reverse Recovery Charge		$T_j = 25^{\circ}C$		56		μC
Qrr			$T_{j} = 125^{\circ}C$		92		μυ
E <sub>rr</sub>	Reverse Recovery Energy		$T_j = 25^{\circ}C$		24		mJ
Ðrr			$T_{j} = 125^{\circ}C$		48		1110

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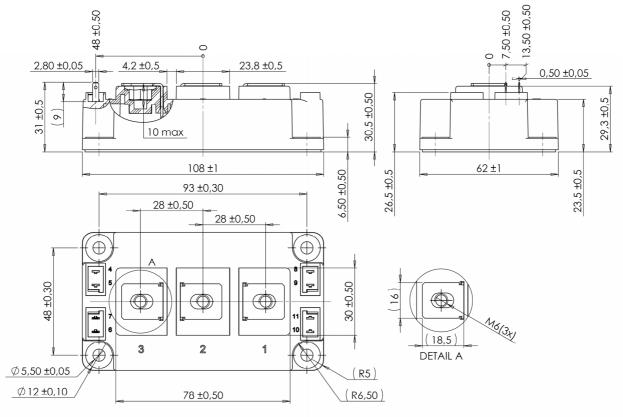


# APTGT200DA170D3G

# Thermal and package characteristics

Symbol	Characteristic			Min	Тур	Max	Unit
R <sub>thJC</sub>	Junction to Case Thermal Resistance IGBT Diode				0.10	°C/W	
<b>R</b> <sub>th</sub> JC			Diode			0.16	C/ W
V <sub>ISOL</sub>	RMS Isolation Voltage, any terminal to case t =1 min, 50/60Hz			4000			V
T <sub>J</sub>	Operating junction temperature range		-40		150		
T <sub>STG</sub>	Storage Temperature Range			-40		125	°C
T <sub>C</sub>	Operating Case Temperature			-40		125	
Torque	Mounting forque	For terminals	M6	3		5	N.m
Torque		To Heatsink	M6	3		5	19.111
Wt	Package Weight					350	g

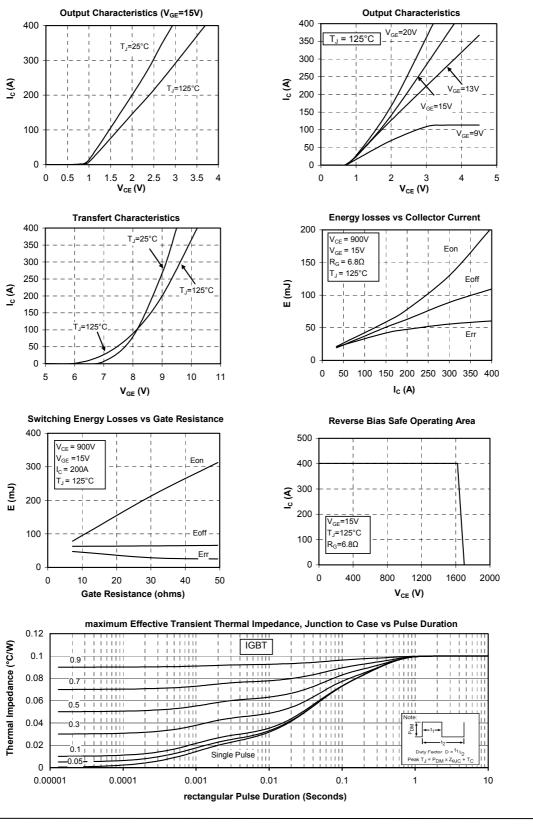
# D3 Package outline (dimensions in mm)



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## **Typical Performance Curve**



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0.04

0.02

0

0.00001

0.1

-0.05

<u>| | | | | |</u>

0.0001

0.001

# APTGT200DA170D3G

i i i

1

Duty Factor D =  $t_{1/t_2}$ 

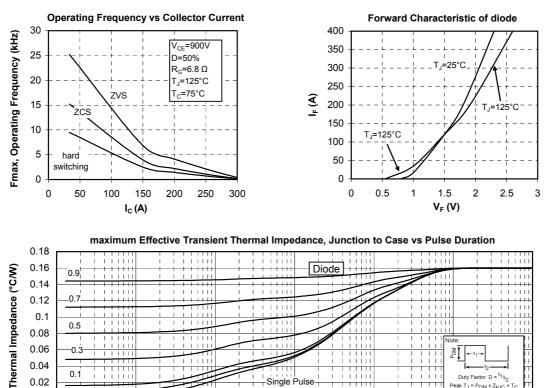
10

Peak T<sub>J</sub> = P<sub>DM</sub> x Z<sub>0JC</sub>

. . . . . .

. . . . .

0.1



Single Pulse

0.01

rectangular Pulse Duration (Seconds)

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# APTGT200DA170D3G

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